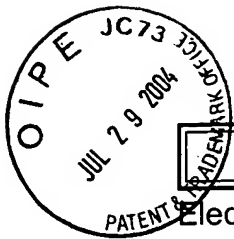


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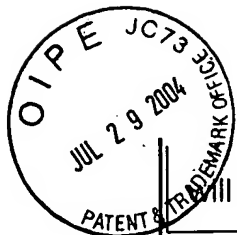
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Application ID: 10056316  
Title of Invention: ENDPOINT DETECTION FOR  
ELECTRO CHEMICAL  
MECHANICAL POLISHING AND  
ELECTROPOLISHING PROCESSES  
First Named Inventor: Alain Duboust  
Domestic/Foreign Application: Domestic Application  
Filing Date: 2002-01-22  
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Submission Type: Information Disclosure  
Statement  
Filing Type:  
Confirmation number: 2878  
Attorney Docket Number: 6339/CMP/CMP  
Total Fees Authorized:

Digital Certificate Holder: cn=Keith Patrick Taboada,ou=Registered Attorneys,ou=Patent and  
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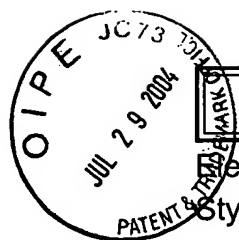
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Electronic Version v1.1  
Stylesheet Version v1.1.0

<b>Title of Invention</b>	<b>ENDPOINT DETECTION FOR ELECTRO CHEMICAL MECHANICAL POLISHING AND ELECTROPOLISHING PROCESSES</b>									
<p>Application Number: 10/056316 </p> <p>Date: 2002-01-22</p> <p>First Named Applicant: Alain Duboust</p> <p>Confirmation Number: 2878</p> <p>Attorney Docket Number: 6339/CMP/CMP</p>										
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<table border="1"><thead><tr><th>Submitted by:</th><th>Elec. Sign.</th><th>Sign. Capacity</th></tr></thead><tbody><tr><td>Keith P Taboada Registered Number: 45150</td><td>/Keith P Taboada/</td><td>Attorney</td></tr></tbody></table>			Submitted by:	Elec. Sign.	Sign. Capacity	Keith P Taboada Registered Number: 45150	/Keith P Taboada/	Attorney		
Submitted by:	Elec. Sign.	Sign. Capacity								
Keith P Taboada Registered Number: 45150	/Keith P Taboada/	Attorney								
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<p><b>Comments</b></p> <p>An additional Information Disclosure Statement citing foreign and articles references</p>										



will be filed by first class mailing.



## ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

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### Title of Invention

### ENDPOINT DETECTION FOR ELECTRO CHEMICAL MECHANICAL POLISHING AND ELECTROPOLISHING PROCESSES

Application Number: 10/056316



Confirmation Number: 2878

First Named Applicant: Alain Duboust

Attorney Docket Number: 6339/CMP/CMP

Art Unit: 1745

Examiner: Thomas Parsons

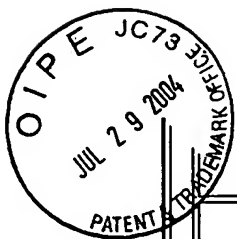
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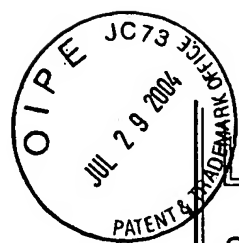


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Note: Applicant is not required to submit a paper copy of cited US Published Applications

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